

Search Notes

Application/Control No.

10/670,992

Examiner

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Applicant(s)/Patent under
Reexamination

KONNO, TAKESHI

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
340	5.62	5/2/2006	NN
340	5.64	5/2/2006	NN
340	10.52	5/2/2006	NN
340	5.7+	5/2/2006	NN
340	426.1	5/2/2006	NN
340	7.5+	5/2/2006	NN
70	252	5/2/2006	NN
70	255	5/2/2006	NN
70	278.1	5/2/2006	NN
307	10.2	5/2/2006	NN
307	10.5	5/2/2006	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SAME AS	ABOVE	5/2/2006	NN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO; and Derwent. (UPDATED SEARCH)	5/2/2006	NN